

Discription

The PESDXXXL1BA protects sensitive semiconductor components from damage or upset due to electrostatic discharge (ESD) and other voltage induced transient events. Excellent clamping capability, low leakage, low capacitance, and fast response time provide best in class protection on designs that are exposed to ESD. It gives designer the flexibility to protect one bi-directional

line in applications where arrays are not practical.



SOD-323

Specification Features:

- 500W peak pulse power (8/20µs)
- · Protects one data or power line
- Ultra low leakage: nA level
- Operating voltage:3.3V, 5V, 12V,15, 24V
- Ultra low clamping voltage
- · Complies with following standards:
 - IEC 61000-4-2 (ESD) immunity test Air discharge: ±30kV Contact discharge: ±30kV
- IEC61000-4-4 (EFT) 40A (5/50ns)
- RoHS Compliant



Circuit Diagram

Ordering information

Product ID	Pack	Qty(PCS)
PESDXXXL1BA	SOD-323	3000

Absolute Ratings (T_{amb}=25°C)

Symbol	Parameter	Value	Units
P _{PP}	Peak Pulse Power (t _p = 8/20 μ s)	500	W
T _L	Maximum lead temperature for soldering during 10s	260	°C
T _{stg}	Storage Temperature Range	-55 to +155	°C
T _{op}	Operating Temperature Range	-40 to +125	°C
T _j	Maximum junction temperature	150	°C
	IEC61000-4-2 (ESD) air discharg contact discharg		KV

Stresses exceeding Maximum Ratings may damage the device. Maximum Rating are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. FR-5 = 1.0*0.75*0.62 in.



Electrical Characteristics (T_A=25°C unless otherwise specified)

PESD3V3L1BA								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			3.3	V			
Breakdown Voltage	VBR	4			V	IT = 1mA		
Reverse Leakage Current	I _R			0.5	μA	VRWM = 5V		
Clamping Voltage	Vc		5		V	IPP = 5A (8 x 20µs pulse)		
Clamping Voltage	Vc		10		V	IPP = 36A (8 x 20µs pulse)		
Peak Pulse Current	Ipp			18	Α	tp = 8/20µs		
Junction Capacitance	Cl			200	pF	VR = 0V, f = 1MHz		

PESD5V0L1BA								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			5	V			
Breakdown Voltage	VBR	8.5			V	IT = 1mA		
Reverse Leakage Current	I _R			1	μΑ	VRWM = 8V		
Clamping Voltage	Vc			11	V	IPP = 5A (8 x 20µs pulse)		
Clamping Voltage	Vc			15	V	IPP = 34A (8 x 20µs pulse)		
Peak Pulse Current	Ipp			15	Α	tp = 8/20µs		
Junction Capacitance	Сл			180	pF	VR = 0V, f = 1MHz		



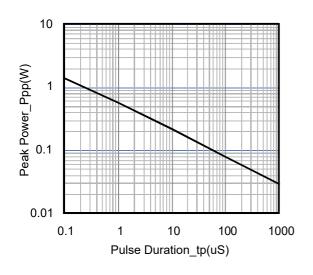
PESD12VL1BA								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			12	V			
Breakdown Voltage	VBR	13.3			V	IT = 1mA		
Reverse Leakage Current	I _R			0.5	μΑ	VRWM = 12V		
Clamping Voltage	Vc			19	V	IPP = 5A (8 x 20µs pulse)		
Clamping Voltage	Vc			28	V	IPP = 18A (8 x 20μs pulse)		
Peak Pulse Current	lpp			10	Α	tp = 8/20µs		
Junction Capacitance	CJ			100	pF	VR = 0V, f = 1MHz		

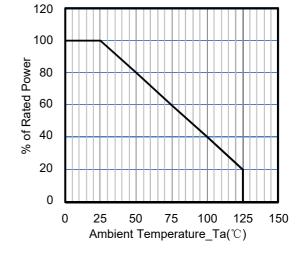
PESD15VL1BA								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			15	V			
Breakdown Voltage	VBR	16.7			V	IT = 1mA		
Reverse Leakage Current	I _R			0.5	μA	VRWM = 12V		
Clamping Voltage	Vc			19	V	IPP = 5A (8 x 20μs pulse)		
Clamping Voltage	Vc			28	V	IPP = 18A (8 x 20µs pulse)		
Peak Pulse Current	lpp			10	Α	tp = 8/20µs		
Junction Capacitance	Cı			100	pF	VR = 0V, f = 1MHz		



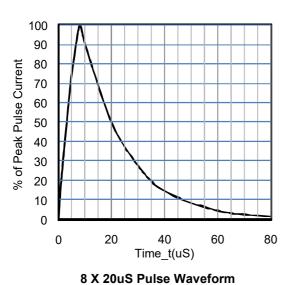
PESD24VL1BA								
Parameter	Symbol	Min	Тур	Max	Unit	Test Condition		
Reverse Working Voltage	VRWM			24	V			
Breakdown Voltage	VBR	27			V	IT = 1mA		
Reverse Leakage Current	I _R			0.2	μA	VRWM = 24V		
Clamping Voltage	Vc			40	V	IPP = 1A (8 x 20µs pulse)		
Clamping Voltage	Vc			62	V	IPP = 8A (8 x 20µs pulse)		
Peak Pulse Current	Ipp			5	Α	tp = 8/20µs		
Junction Capacitance	Cl			50	pF	VR = 0V, f = 1MHz		

Typical Performance Characteristics (T_A=25°C unless otherwise Specified)





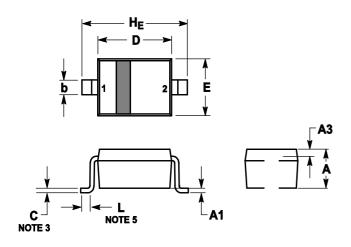
Peak Pulse Power vs. Pulse Time



Power Derating Curve



OUTLINE AND DIMENSIONS

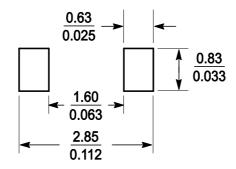


Notes:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

	MIL	LIMETE	ERS	I	INCHES	3	
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.8	0.9	1	0.031	0.035	0.04	
A1	0	0.05	0.1	0	0.002	0.004	
A3	().15REI	=	0.006REF			
b	0.25	0.32	0.4	0.01	0.012	0.016	
C	0.089	0.12	0.177	0.003	0.005	0.007	
D	1.6	1.7	1.8	0.062	0.066	0.07	
Е	1.15	1.25	1.35	0.045	0.049	0.053	
L	0.08			0.003			
H _E	2.3	2.5	2.7	0.09	0.098	0.105	

SOLDERING FOOTPRINT



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